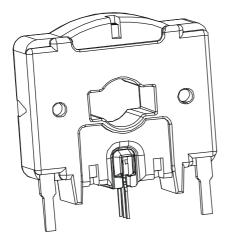
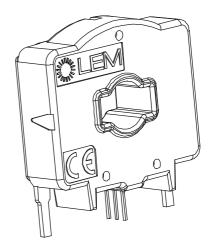


AUTOMOTIVE CURRENT TRANSDUCER HC6H1000-S









HC6H1000-S

Introduction

The HC6H Family is for use on the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with a galvanic isolation between the primary circuit (high power) and the secondary circuit (electronic circuit).

The HC6H family gives you the choice of having different current measuring ranges in the same housing.

Features

- Open Loop transducer using the Hall effect
- Low voltage application
- Unipolar + 5 V DC power supply
- Standard primary current measuring range from 200 A up to 800 A
- Maximum rms primary admissible current: defined by busbar the magnetic core or the ASIC to have T° < + 150°C
- Operating temperature range: 40°C < T° < + 125°C
- Output voltage: full ratio-metric (in gain and offset)
- Compact design for PCB mounting.

Advantages

- Excellent accuracy
- Very good linearity
- Very low thermal offset drift
- Very low thermal gain drift
- Wide frequency bandwidth
- No insertion losses
- Very good ratio size/current range.

Automotive applications

- Starter Generators
- Converters
- Inverters
- Drives.

Principle of HC6H Family

The open loop transducers use an Hall effect integrated circuit. The magnetic induction B, contributing to the rise of the Hall voltage, is generated by the primary current I_p to be measured. The control current I_p is supplied by a current source i.e. battery or generator (Fig. 1).

Within the linear region of the hysteresis cycle, B is proportional to:

$$B(I_{p}) = constant(a) \times I_{p}$$

The Hall voltage is thus expressed by:

$$\mathbf{V}_{\mathrm{H}} = (\mathbf{R}_{\mathrm{H}}/\mathrm{d}) \times \mathbf{I}_{\mathrm{h}} \times \mathrm{constant} (\mathrm{a}) \times \mathbf{I}_{\mathrm{p}}$$

Except for $\mathbf{I}_{\mathbf{p}},$ all terms of this equation are constant. Therefore:

 $\mathbf{V}_{_{\mathrm{H}}}$ = constant (b) x $\mathbf{I}_{_{\mathrm{P}}}$

The measurement signal $\rm V_{_{H}}$ amplified to supply the user output voltage or current.

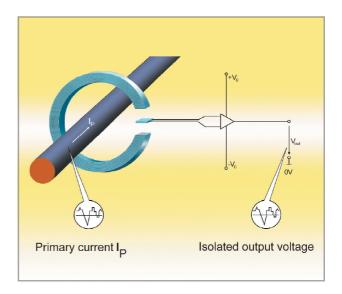


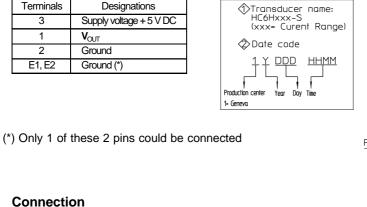
Fig. 1: Principle of the open loop transducer

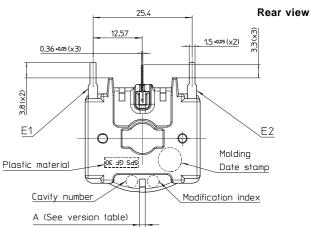


Dimensions HC6Hxxx-S family (in mm. 1mm = 0.0394 inch)

Secondary connection

Terminals	Designations
3	Supply voltage + 5 V DC
1	Vout
2	Ground
E1, E2	Ground (*)





14.75

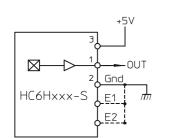
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10.5 +0.3

28.2

Front view

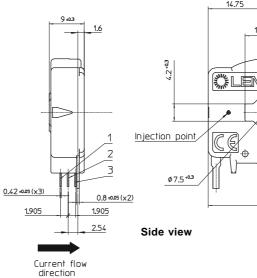
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xxx= Current Range

Connection

VERSION TA	BLE of CURRENT RANGE
А	CURRENT RANGE
1.5 mm	I _P <= 600 A
3 mm	I _P > 600 A

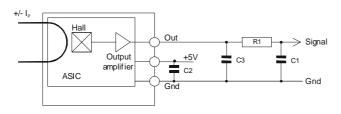


Bill of materials

- Plastic case
- Magnetic core
- Pins

Mass

Electronic schematic



SPS GF 30

FeSi alloy

23 g

Copper alloy tin platted (lead free) Remarks

- General tolerance ± 0.2 mm
- $V_{OUT} > \frac{V_c}{2}$ when I_p flows in the direction of the arrow.

Power supply decoupling capacitor: C2 = 47 nF EMC protection capacitor : C3 = 4.7 nF

Optional : High frequency signal noise filter: $R1 > 100 \Omega$

C1 = defined according to the system frequency bandwidth.



HC6H1000-S

Absolute maximum ratings (not operating)

Parameter	Symbol	Unit	Specification	Conditions
Maximun peak primary current (not operating)	I _{P max}	A	Defined by busbar to have $T^{\circ} \leq 150^{\circ}C$	
Primary nominal DC or current rms	I _{PN}	A	Defined by busbar to have $T^{\circ} \leq 150^{\circ}C$	
Maximun supply voltage (not operating)	V _{C max}	V	7	
Secondary maximum admissible power	P S max	m W	150	
Ambient operating temperature	T _A	°C	- 40 < T _A < 125°C	
Ambient storage temperature	Ts	°C	- 40 < T _S < 125°C	
Electrostatic discharge voltage	V ESD	V	2000	JESD22-A114-B
Maximum admissible vibration	γ	m.s ⁻²	3)	see note ³⁾
Rms voltage for AC isolation test 50 Hz, 1 min	V _d	V	2000	IEC 60664-1

Operating characteristics

		Symbol Unit		Specification			Conditions
		Symbol		Min	Typical	Max	Conditions
			El	ectrical Da	ita		
Primary current, measuring rar	nge	I _{PM}	A	-1000	-	1000	@ - 40°C < T° < 125°C
Supply voltage 1)		Vc	V	4.75	5	5.25	@ - 40°C < T° < 125°C
Output voltage (Analog)		V _{OUT}	V	$V_{OUT} = V_{C}$	/5 x (2.5 +	0.0020 x I _P)	@ - 40°C < T° < 125°C
Sensitivity -	800A <i<sub>P<800A</i<sub>	G	V/A	0.00196	0.0020	0.00204	@ T _A = 25°C
Offset voltage		Vo	V	2.480	2.500	2.520	@ $V_{C} = 5 V$; $T_{A} = 25^{\circ}C$; $I_{P} = 0A$
Current consumption		Ιc	mA	-	15	20	@ - 40°C < T° < 125°C; 4.75 V < $V_{\rm C}$ < 5.25 V
Load resistance		RL	KΩ	2	-	-	
Output internal resistance		R _{OUT}	Ω	-	-	10	
			Per	formance I	Data		
Sensitivity error - 8	800A < I _P <800A	ε _G	%	-2.0	±0.7	2.0	@ $T_A = 25^{\circ}C$, $V_C = 5 V$; Gth = 0.0020V/A
,	000A d _P <-800A	εg	%		±1.5		@ TA = 25°C, V_{C} = 5 V; Gth = 0.0020V/A
800A <i<sub>P<1000A</i<sub>	00A <i<sub>P<1000A</i<sub>		A	-6.0	±2.5	6.0	
Electrical offset		I _{OE} V _{OE}	mV	-12.0	±5.0	12.0	@ $V_{C} = 5 \text{ V}; T_{A} = 25^{\circ}\text{C}$
		I _{OM}	A	-4.0	±2.5	4.0	
Magnetic offset		V _{OM}	mV	-8.0	±5	8.0	@ After excursion to $\pm I_P$; $T_A = 25^{\circ}C$
T		TCIOE	mA/°C	-80	±40	80	
Temperature coefficient of		TCVOE	mV/°C	-0.16	±0.08	0.16	@ - 40°C < T° < 125°C; $V_{C} = 5.0 \text{ V}$
Temperature coefficient of G	- 800A < I _P <800A	TCG	%/°C	-0.04	±0.02	0.04	@ - 40°C < T° < 125°C; $V_{C} = 5.0 \text{ V}$
Linearity error -	800A <i<sub>P<800A</i<sub>	e	% I _P	-1.0	±0.5	1.0	@ I_P ; $V_C = 5 V$, $T_A = 25^{\circ}C$
Linearity error - 1	000A d _P <-800A		o/ 1				
800A d _P <	800A d _P <1000A	e_	% I _P		±3.5		@ I_{P} ; $V_{C} = 5 V$, $T_{A} = 25^{\circ}C$
Response time		tr	μs	-	10	15	@ di/dt = 50 A/µs; I _T = 600 A
Frequency bandwidth 2)		BW	kHz	20	-	-	@ -3 dB; I _T = 100 A rms
Output voltage noise peak-pea	k	V _{no p-p}	mV	-	12	16	@ T _A = 25°C; 0 Hz < f < 1 MHz
Output voltage noise rms		V _{no rms}	mV	-	3.0	4.0	@ T _A = 25°C; 0 Hz < f < 1 MHz

<u>Notes</u>: ¹⁾ The output voltage V_{OUT} is fully ratio-metric and depends on the supply voltage V_{c} The V_{c} value must be measured and used with the following formula:

$$I_{P} = \left(V_{OUT} - \frac{V_{c}}{2}\right) \times \frac{1}{G} \times \frac{5}{V_{c}} \qquad with \ G \ in \ (V/A)$$

²⁾ Small signal only to avoid excessive heatings of the busbar, the magnetic core and the ASIC.

³⁾ Depending on the customer application's set up.



PERFORMANCE PARAMETERS DEFINITIONS

Sensitivity:

The Transducer's sensitivity **G** is the slope of the straight line $V_{OUT} = f(I_p)$, it must establish the relation:

 $V_{OUT}(I_{P}) = V_{C}/5 (G \times I_{P} + 2.5) (*)$

* For all symetrics transducers

Offset voltage:

Is the output voltage when the primary current is null. The ideal value of $V_{\rm O}$ is $V_{\rm C}/2$. So, the difference of $V_{\rm O}$ - $V_{\rm C}/2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis.

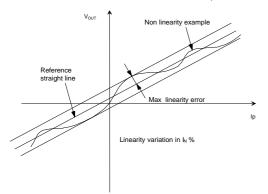
Magnetic offset:

The magnetic offset is the consequence of an over-current on the primary side. It's defined after an excursion of ${\rm I}_{\rm p}$ max.

Linearity:

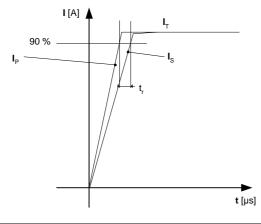
Is the maximum positive or negative discrepancy with a reference straight line $V_{_{OUT}}$ = f (I_P).

Unit: linearity (%) expressed with full scale of $\rm I_{\rm p}$ max.



Response time (delay time) t,:

Is the time between the primary current signal and the output signal reach at 90 % of its final value.



Output noise voltage:

The output voltage noise is the result of the noise floor of the Hall elements and the linear $\rm I_c$ amplifier sensitivity.

Offset drift:

The error of the offset in the operating temperature \mathcal{E} Offset is the relative variation of the offset in the temperature considered with the initial offset at 25°C. The offset temperature coefficient **TCV**_{OE} (**TCI**_{OE}) in the operating temperature is the slope off \mathcal{E} Offset = f (T).

Sensitivity drift:

The error of the sensitivity in the operating temperature Sensitivity Error is the relative variation of the sensitivity in the temperature considered with the initial sensitivity at 25°C. Sensitivity temperature coefficient **TCG**.

Typical:

Theorical value or usual accuracy recorded during the production.

Environmental test specifications (Target)

Name	Standard	Conditions				
Thermal shocks	IEC 60068 Part 2-14	T° - 40°C to 125°C /1000 cycles not connected				
Low T [°] operation at min supply voltage	IEC 60068 Part 2-1	T° - 40°C / 1000 H supply voltage = 4.75 V				
High T° operation at max supply voltage	IEC 60068 Part 2-2	T° 125°C / 1000 H supply voltage = 5.25 V				
Temperature humidity bias	IEC 60068 Part 2-3	T° 85°C / 85 % RH/ 1000 H				
Mechanical Tests						
Vibration	IEC 60068 Part 2-64	see note ³⁾ page 4				
Drop test	IEC 60068 Part 2-29	Height 750 mm concrete floor each directions				
	EMC Test					
Electrostatic discharge	JESD22-A114-B	Applied voltage = $\pm 2 \text{ kV}$ pin to pin number of discharge = 1				
Rms voltage for AC isolation test	IEC 60664 Part 1	2 kV, 50 Hz, 1 min				
Bulk current injected- radiated immunity	ISO 11452 Part 4					